Shao-Ting Chiu's Exam Note for ECEN638 October 28, 2022

### **Chapter 2: Optimal Classification**

- $\begin{array}{lll} \bullet & \mathbf{Error} & \mathbf{of} & \mathbf{classifier} & \vdots & \epsilon[\psi(x)] &=& P(\psi(X) \neq \\ Y) &=& \underbrace{p(\psi(X)=1|Y=0)}_{\epsilon^0 = \int_{(x|\psi(x)=1)}} \underbrace{p(x|Y=0)dx}_{p(x|Y=0)} \\ &\underbrace{p(\psi(X)=0|Y=1)}_{\epsilon^1 = \int_{(x|\psi(x)=0)} \underbrace{p(x|Y=1)dx}_{p(x|Y=1)dx} \\ \end{array}$
- Cond. error:  $\epsilon[\psi|X] = P(\psi(X) \neq Y|X = x) = P(\psi(X) = 0, Y = 1|X = x) + P(\psi(X) = 1, Y = 0|X = x) = I_{\{\psi(x)=0\}}\eta(x) + I_{\{\psi(x)=1\}}(1 \eta(x))$
- Post.prob.func.:  $\eta(x) = E[Y|X=x] = P(Y=1|X=x)$
- Sensitivity:  $1 \epsilon^1[\psi]$ ; Specificity:  $1 \epsilon^0[\psi]$
- Thm. Bayes classifier:

$$\psi^*(x) = \arg\max_i P(Y=i|X=x) = \begin{cases} 1, & \eta(x) > \frac{1}{2} \\ 0, & \text{otherwise} \end{cases} \tag{1}$$

- Thm. Bayes Error:  $\epsilon^* = P(Y=0)\epsilon^0[\psi^*] + P(Y=1)\epsilon^1[\psi^*] = E[\min\{\eta(X), 1-\eta(x)\}] = \frac{1}{2} \frac{1}{2} E[|2\eta(X)-1|]$
- $\begin{array}{lll} \bullet & \mathbf{Bayes} & \mathbf{class.:} & \psi^*(x) \\ & \text{opt. discriminant} & \text{opt. threshold} \\ 1 & \widehat{D^*(x)} & > & \widehat{k^*} \\ & = P(Y=1)p(x|Y=1) > \\ & P(Y=0)p(x|Y=0) \\ 0, & \text{otherwise} \end{array}$
- $D^*(x) = \ln \frac{p(x|Y=1)}{p(x|Y=0)}$ ;  $k^* = \ln \frac{P(Y=0)}{P(Y=1)}$

Gaussian Prob.: p(x|Y=i)  $\frac{1}{\sqrt{(2\pi)^d\det(\Sigma_i)}}\exp[\frac{1}{2}(x-\mu)^T\Sigma_i^{-1}(x-\mu_i)]$ 

- $\begin{array}{lll} \bullet & D^*(x) &=& \frac{1}{2}(x \, \, \mu_0)^T \Sigma_0^{-1}(x \, \, \mu_0) \, \, \frac{1}{2}(x \, \, \mu_1)^T \Sigma_1^{-1}(x \mu_1) + \frac{1}{2} \ln \frac{\det(\Sigma_0)}{\det(\Sigma_1)} \end{array}$
- **Homo.** Case:  $\sqrt{(x_0 x_1)^T \Sigma^{-1} (x_0 x_1)}$  Let  $||x_0 x_1||_{\Sigma} = ||x_0||^2 =$
- $\psi_L^*(x) = \begin{cases} 1, & \|x \mu_1\|_{\Sigma}^2 < \|x \mu_0\|_{\Sigma}^2 + 2\ln\frac{P(Y=1)}{P(Y=0)} \\ & = a^Tx + b > 0 \\ 0, & \text{otherwise} \end{cases}$
- $a = \Sigma^{-1}(\mu_1 \mu_0) / b = (\mu_0 \mu_1)^T \Sigma^{-1}(\frac{1}{2});$  $b = (\mu_0 - \mu_1)^T \Sigma^{-1}(\frac{\mu_0 + \mu_1}{2}) + \ln \frac{P(Y=1)}{P(Y=0)};$
- $\begin{array}{lll} \bullet & \epsilon_L^* &=& c\Phi(\frac{k^*-\frac{1}{2}\delta^2}{\delta}) \,+\, (1 c)\Phi(\frac{-k^*-\frac{1}{2}\delta^2}{\delta}), \delta &=& \\ & \sqrt{(\mu_1-\mu_0)^T \Sigma^{-1}(\mu_1-\mu_0)} & \end{array}$

 $\begin{array}{lll} \textbf{Heter.} & \textbf{Case:} & \psi_Q^*(x) & = \\ 1, & x^TAx + b^Tx + c > 0, \\ 0, & \text{otherwise} \end{array}$ 

- $A = \frac{1}{2}(\Sigma_0^{-1} \Sigma_1^{-1})$
- $b = \Sigma_1^{-1} \mu_1 \Sigma_0^{-1} \mu_0$
- $c = \frac{1}{2}(\mu_0^T \Sigma_0^{-1} \mu_0 \mu_1^T \Sigma_1^{-1} \mu_1) + \frac{1}{2} \ln \frac{\det \Sigma_0}{\det \Sigma_1} + \ln \frac{P(Y=1)}{P(Y=0)}$

# Chapter 3: Sample-Based Classification

• No-Free-Lunch: One can never know if their finite-sample performance will be satisfactory, no matter how large n is.  $E[\epsilon_n] \geq \frac{1}{2} - \tau$ 

# Chapter 4: Parametric Classification

LDA — Homo. Gaussian Case

- Linear Discriminant Analysis (LDA):  $\hat{\Sigma}_0^{ML} = \frac{1}{N_0-1} \sum_{i=1}^n (X_i \hat{\mu}_0) (X_i \hat{\mu}_0)^T I_{Y_i=0}, \\ \hat{\Sigma} = \frac{\hat{\Sigma}_0 + \hat{\Sigma}_1}{2}$ 
  - Boundary:  $a_n^T x + b_n = k_n$ .
    - $* a_n = \hat{\Sigma}^{-1}(\hat{\mu}_1 \hat{\mu}_0) = \begin{bmatrix} a_1 \\ a_2 \end{bmatrix}$
  - $* \ b_n = (\hat{\mu}_0 \hat{\mu}_1)^T \hat{\Sigma}^{-1} (\frac{\hat{\mu}_0 + \hat{\mu}_1}{2}) = number$
- Diagnoal LDA: Make  $\hat{\Sigma} \to \hat{\Sigma}_D = \begin{bmatrix} \Sigma_{1,1} & 0 \\ 0 & \Sigma_{2,2} \end{bmatrix}$
- Nearest-Mean Class.(NMC):  $\hat{\Sigma}_M = \begin{bmatrix} \hat{\sigma}_{ij}^2 & 0 \\ 0 & \hat{\sigma}_{ij}^2 \end{bmatrix}$ .  $\hat{\sigma}^2 = \sum_{k=1}^d (\hat{\Sigma})_{kk}$ . Given  $k_n = 0$ ,  $a = \hat{\mu}_1 \hat{\mu}_0$   $b = (\hat{\mu}_0 \hat{\mu}_1)^T \left(\frac{\hat{\mu}_0 + \hat{\mu}_1}{2}\right)$ . Boundary is  $\bot$  means
- 2D:  $a_1x_1 + a_2x_2 + b_n = 0$
- Logistic Class.: linear classification
  - $\begin{array}{l} \ logit(\eta(x|a,b)) = \ln(\frac{\eta(x|a,b)}{1-\eta(x|a,b)}) = a^Tx + b \\ \ L(a,b|S_n) = \ln\left(\prod_{i=1}^n P(Y=Y_i|X=X_i)\right) = \\ \sum_{i=1}^n \ln(\eta(X_i|a,b)^{Y_i}(1-\eta(X_i|a,b))^{1-Y_i}) \end{array}$
- LDA Classifier:  $\psi_n(x)$   $\begin{cases} 1, & a_n^T + b_n > 0 \\ 0, & \text{otherwise} \end{cases}$
- $\bullet \ \epsilon_n = (1-c)\Phi\left(\frac{a_n^T\mu_0 + b_n}{\sqrt{a_n^T\Sigma_0 a_n}}\right) + c\Phi\left(-\frac{a_n^T\mu_1 + b_n}{\sqrt{a_n^T\Sigma_1 a_n}}\right)$

#### QDA — Heter. Gaussian Case

• Boundry:  $x^T A_n x + b_n^T x + c + n = k_n$ 

- $\begin{array}{lll} -\ A_n = -\frac{1}{2}(\hat{\Sigma}_1^{-1} \hat{\Sigma}_0^{-1}) = \begin{bmatrix} a_{11} & a_{12} \\ a_{12}^{-1} & a_{22}^{-1} \end{bmatrix} \\ -\ b_n = \hat{\Sigma}_1^{-1}\hat{\mu}_1 \hat{\Sigma}_0^{-1}\hat{\mu}_0 = \begin{bmatrix} b_1 \\ b_2 \end{bmatrix} \\ -\ c_n = -\frac{1}{2}(\hat{\mu}_1^T\hat{\Sigma}_1^{-1}\hat{\mu}_1 \hat{\mu}_0^T\hat{\Sigma}_0^{-1}\hat{\mu}_0) \ -\ (\frac{1}{2}\ln|\frac{\hat{\Sigma}_1}{|\hat{\Sigma}_0|}) = number \end{array}$
- $\bullet \ \ 2\text{D:}\ a_{11}x_1^2 + 2a_{12}x_1x_2 + a_{22}x_2^2 + b_1x_1 + b_2x_2 + c = 0$

#### Chapter 5:

- $\eta_{n,h}(x) = \sum_{i=1}^{n} W_{n,h}(x,X_i) I_{Y_i=1}$ .
- Weights:  $W_{n,h}(x,X_i) \geq 0;$   $\sum_{i=1}^{n} W_{n,h}(x,X_i) = 1$
- $\begin{cases} \textbf{0.1 Plug-in classifier:} & \psi_n(x) \\ 1, & \sum_{i=1}^n W_{n,h}(x,X_i)I_{Y_i=1} > \\ & \sum_{i=1}^n W_{n,h}(x,X_i)I_{Y_i=0} \\ 0, & \text{otherwise} \end{cases}$
- Kernel Class.:  $W_{n,h}(x,X_j)=\frac{k(\frac{x-X_j}{h})}{\sum_{i=d}^n k(\frac{x-X_i}{h})}.$  h is the kernel bandwidth (smoothing parameter). Small  $h \to \text{overfitting}$
- Thm. Cover-Hart:  $\epsilon_{NN} = E[2\eta(X)(1-\eta(x))]$
- $\bullet \ \ \epsilon_{kNN} = E[\alpha_k(\eta(X))].$
- $\alpha_k(p) = \sum_{i=1}^{(k-1)/2} {k \choose i} p^{i+1} (1 p)^{k-1} + \sum_{i=(k+1)/2}^{k} {k \choose i} p^i (1-p)^{k+1-i}$
- Find  $p_0$  s.t.  $a_k=\alpha_k^{'}(p_0)=\frac{\alpha_k(p_0)}{p_0}.$   $a_k>1,$   $p\in[0,\frac{1}{2}]$
- Thm. Asymptotic class. error of NN:  $\epsilon_{NN} = \begin{cases} 2\epsilon^* (1 \epsilon^*) \text{ iff } \eta(X) \in \{\epsilon^*, 1 \epsilon^* *\} \\ \epsilon^* \text{ iff } \eta(X) \in \{0, \frac{1}{2}, 1\} \end{cases}$
- Stone's Thm: The class. rule is universally consistent, if
  - 1.  $\sum_{i=1}^{n} W_{n,i}(X) I_{\|X_i X\| > \delta} \to^P 0$ , as  $n \to \infty$ , for all  $\delta > 0$
  - 2.  $\max_{i=1,\dots,n} W_{n,i}(X) \to^p 0$ , as  $n \to \infty$
  - 3. There ia a constant  $c\geq 1$  such that , for every nonnegative  $f:R^d\to R$ , and all  $n\geq 1$ ,  $E[\sum_{i=1}^n W_{n,i}(X)f(X_i)]\leq cf(X)$
- Uni. Consist. of Histrogram Class.:
  - $-\ diam[A_n(X)]=\sup_{x,\,y\in A_n(X)}\|x-y\|\to 0$  in probability.  $-\ N_n(X)\to \infty$
- Uni. Consist. of Cubic Histogram: Let  $V_n = h_n^d$ . If  $h_n \to 0$ , but  $nV_n \to \infty$  as  $n \to \infty$ . Then  $E[\epsilon_n] \to \epsilon^*$
- Uni. Consist. of kNN: If  $K \to \infty$  while  $\frac{K}{n} \to 0$  as  $n \to \infty$ . Then  $E[\epsilon_n] \to \epsilon^*$ .
- Uni. Consist. of Kernel:  $h_n \to 0$  with  $nh_n^d \to \infty$  as  $n \to \infty$ . (kernel k is nonnegative, cont. integrable)

### **Key points & Definitions**

- The posterior probability function is needed to define the Bayes classifier.; Bayes error is optimal error; LDA is parameteric.
- minimum and the maximal of the Bayes error of binary classification:  $\epsilon^* = E[\min\{\eta(X), 1 \eta(X)\}].$
- expected classification error  $\mu = E[error_n]$  not a function of the training data?:  $\mu_n$  is data-independent, it is a function only of the classifiction rule.
- meaning of an error estimator is optimistically biased?: Be significantly smaller on average than the true error, due to overfitting. When the bias < 0, and left shifted.
- Is a consistent classification rule always better than a non-consistent one and why?: No. non-consist. is better when n is small because consist. class. thed to be complex.
- If a classifier is overfitted, will its apparent error?: Apparent error is smaller due to small sample size.
- The penalty term in an SVM?: Small C includes outlier (soft margin and less overfitting)
- Cover-Hart Thm.: The expected error of the NN classification rule satisfies  $\epsilon_{NN}=\lim_{n\to\infty}E[\epsilon_n]=E[2\eta(X)(1-\eta(X))].$   $\epsilon_{NN}\leq 2\epsilon^*(1-\epsilon^*)\leq 2\epsilon^*.$  "The error of the nearest-neighbot classifier with a large sample size cannot be worse than two times the Bayes error."  $\epsilon_{NN}\geq\epsilon_{3NN}\geq\epsilon^*$
- Ch. 1: Curse of dimen. (peaking phen.): With fixed sample size, class. error improve with more features, then decreases.
- Scissors Effect: Simpler classification rules can perform better under small sample sizes. On the contray in big data.
- Ch. 3: Classification rule vs. classifier: output classifiers; class lables. Consistency: As n → ∞,
  ϵ<sub>n</sub> → ϵ\*
- Ch. 5: Nonparametric class. has no assumption about the shape of the distributions. use smoothing. Selecting right amount of smoothing given n and complexity of dist. Weights: adding the influences of each data point  $(X_i, Y_i)$ . 3/5NN rule are better than 1NN under small sample size

#### Math facts

- Bayes:  $P(Y = 0|X = x) = \frac{P(Y=0)P(x|Y=0)}{P(x)}$
- $\det \begin{bmatrix} a & b \\ c & d \end{bmatrix} = ad bc$ ;  $\begin{bmatrix} a & b \\ c & d \end{bmatrix}^{-1} = \frac{1}{ad-bc} \begin{bmatrix} -d & -b \\ -d & a \end{bmatrix}$
- Affine trans. f(x) = AX + B. If  $X \sim N(\mu, \Sigma)$ ,  $a^T X + b \sim N(A^T \mu + b, A^T \Sigma A)$ .
- Convergence in prob.:  $X_n \to^P X$ .  $\lim_{n\to\infty} P(|X_n-X|>\tau)=0$ , for all  $\tau>0$ . Implies that  $f(X_n)\to^P f(X)$
- Gauss. CDF:  $1 \Phi(-a) = \Phi(a)$